

Notice of References Cited	Application/Control No. 10/747,886	Applicant(s)/Patent Under Reexamination JEON, BYEONG WOOK	
	Examiner Eric S. McCall	Art Unit 2855	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0249540	12-2004	Saitou et al.	701/051
*	B	US-2004/0192484	09-2004	Watanabe et al.	475/116
*	C	US-6,575,047	06-2003	Reik et al.	73/862.191
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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